SPECIFICATION FOR LCD MODULE

Model No. _____TM132128ABCWG

Prepared by:	Date:
Checked by :	Date:
Verified by :	Date:
Approved by:	Date:

TIANMA MICROELECTRONICS CO., LTD MM. Data Rev 10

REVISION RECORD

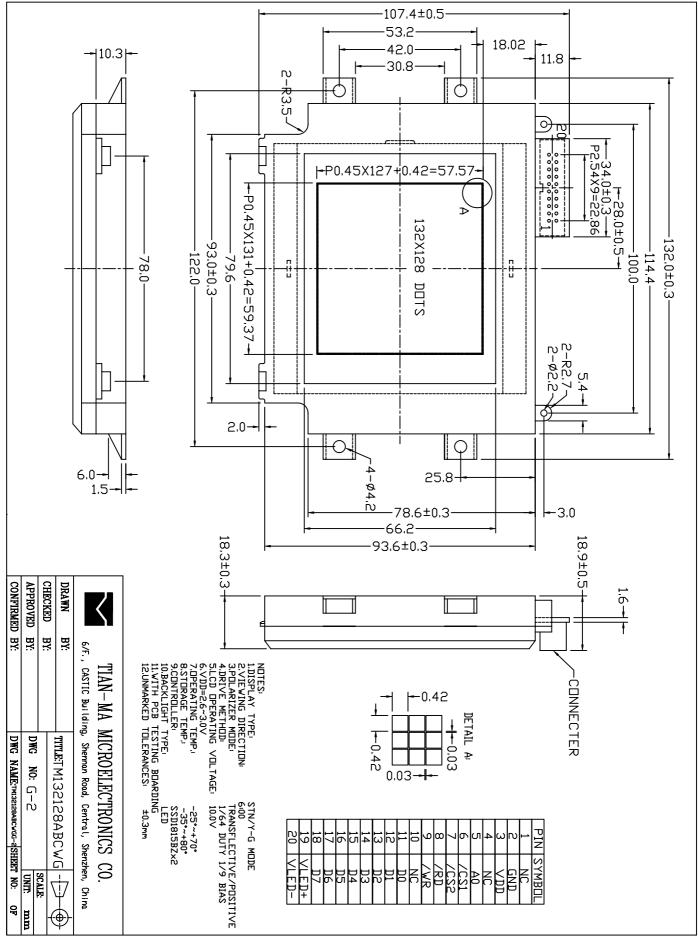
Date	Ref. Page	Revision No.	Revision Items	Check & Approval

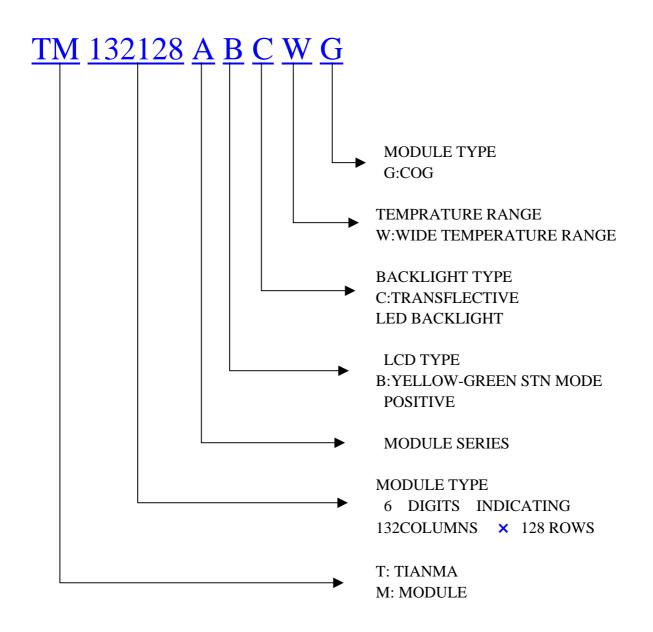
1 General Specifications:

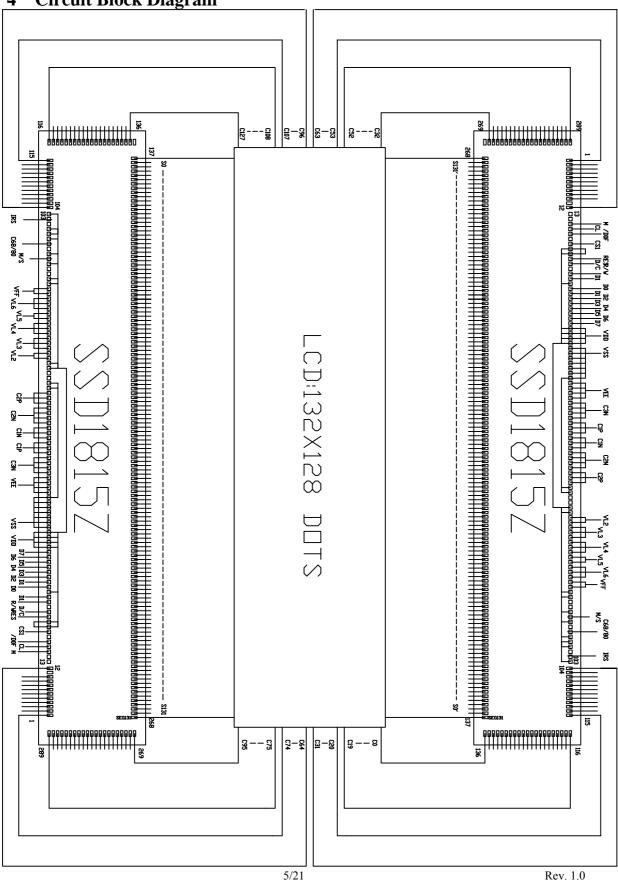
1.1 Display type: STN
1.2 Display color* ¹ :
Display color: Blue-Black
Background* ² : Yellow-Green
1.3 Polarizer mode: Transflective/Positive
1.4 Viewing Angle: 6:00
1.5 Driving Method: 1/64 Duty 1/9 Bias
1.6 Backlight: LED
1.7 Controller: SSD1815BZ × 2
1.8 Data Transfer: 8 Bit Parallel
1.9 Operating Temperature: -25+70
Storage Temperature: -35+80
1.10 VDD: 2.6~3.0V
1.11 LCD Operating Voltage: 10.0V
1.12 Outline Dimensions: Refer to outline drawing on next page
1.13 Dot Matrix: 132 × 128 Dots
1.14 Dot Size: 0.42×0.42 (mm)
1.15 Dot Pitch: 0.45×0.45 (mm)
1.16 Weight:about 140g

*¹ Color Tone is slightly changed by temperature and driving voltage.
*² Color Tone will be changed by backlight.

2 Outline Drawing







Circuit Block Diagram 4

Item	Symbol	Min.	Max.	Unit	Remark
Power Supply Voltage	Vdd - Vss	-0.3	6.0	v	
LCD Driving Voltage	VLCD	-	25.0	v	
Operating Temperature Range	Тор	-25	+70		No
Storage Temperature Range	Тѕт	-35	+80		Condensation

5 Absolute Maximum Ratings

6 Electrical Specifications and Instruction Code

6.1 Electrical characteristics

Iten	n	Symbol	Min.	Тур.	Max.	Unit
Supply V (Log	-	Vdd - Vss	2.75	3.0	3.25	V
Supply V (LCD D	-	Vlcd	-	10.0	-	V
Input	High	V _{IH} (V _{DD} =3.0)	$0.8 \mathrm{V_{DD}}$	-	V _{DD} +0.3	V
Signal Voltage Low		V _{IL} (V _{DD} =3.0)	0	-	0.2 V _{DD}	V
Supply c (Log		I_{DD} (V _{DD} - V _{SS} =3.0V)	-	-	750	mA
Supply current (LCD Drive)		\mathbf{I}_{EE}	-	-	300	mA
Supply current (LED Drive)		Supply current I _{LED}		-	90.0	mA

6.2 Interface Signals

Pin No.	Symbol	Level	Description
1	NC		No Signal
2	GND	0 V	Ground
3	VDD	3.0V	Power supply voltage for logic and LCD(+)
4	NC		No Signal
5	A0	H/L	Data type(H:Instruction;L:Data)
6	$\overline{CS1}$	H/L	Chip Enable Signal (Active at low)
7	CS2	H/L	Chip Enable Signal (Active at high)
8	RD	H/L	Read Signal (Active at low)
9	WR	H/L	Write Signal (Active at low)
10	NC		No Signal
11	DB0	H/L	Data bit0
12	DB1	H/L	Data bit1
13	DB2	H/L	Data bit2
14	DB3	H/L	Data bit3
15	DB4	H/L	Data bit4
16	DB5	H/L	Data bit5
17	DB6	H/L	Data bi6
18	DB7	H/L	Data bit7
19	VLED+	3.6V	Backlight power supply pin (+)
20	VLED-	0 V	Backlight power supply pin (-)

6.3 Interface Timing Chart

Symbol	Parameter	Min	Тур	Max	Unit
t _{cycle}	Clock Cycle Time	300	-	-	ns
t _{AS}	Address Setup Time	0	-	-	ns
t _{AH}	Address Hold Time	0	-	-	ns
t _{DSW}	Write Data Setup Time	40	-	-	ns
t _{DHW}	Write Data Hold Time	15	-	-	ns
t _{DHR}	Read Data Hold Time	20	-	-	ns
t _{OH}	Output Disable Time	-	-	70	ns
t _{ACC}	Access Time	-	-	140	ns
PW _{CSL}	Chip Select Low Pulse Width (read)	120	-	-	ns
	Chip Select Low Pulse Width (write)	60	-	-	ns
PW _{CSH}	Chip Select High Pulse Width (read)	60	-	-	ns
	Chip Select High Pulse Width (write)	60	-	-	ns
t _R	Rise Time	-	-	15	ns
t _F	Fall Time	-	-	15	ns

Parallel Timing Characteristics (T _A=25°C, V_{DD}=2.7V, V_{SS}=0V)

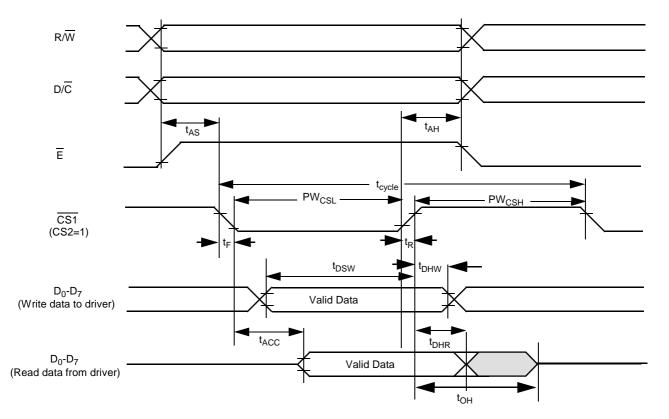


Figure 1. Parallel 6800-series Interface Timing Characteristics

Symbol	Parameter	Min	Тур	Max	Unit
t _{cycle}	Clock Cycle Time	300	-	-	ns
t _{AS}	Address Setup Time	0	-	-	ns
t _{AH}	Address Hold Time	0	-	-	ns
t _{DSW}	Write Data Setup Time	20	-	-	ns
t _{DHW}	Write Data Hold Time	40	-	-	ns
t _{DHR}	Read Data Hold Time	20	-	-	ns
t _{OH}	Output Disable Time	-	-	70	ns
t _{ACC}	Access Time	-	-	140	ns
PW _{CSL}	Chip Select Low Pulse Width (read)	120	-	-	ns
	Chip Select Low Pulse Width (write)	60	-	-	ns
PW _{CSH}	Chip Select High Pulse Width (read)	60	-	-	ns
	Chip Select High Pulse Width (write)	60	-	-	ns
t _R	Rise Time	-	-	15	ns
t _F	Fall Time	-	-	15	ns

Parallel Timing Characteristics (T $_{A}\text{=}25^{\circ}\text{C},\,\text{V}_{\text{DD}}\text{=}2.7\text{V},\,\text{V}_{\text{SS}}\text{=}0\text{V})$

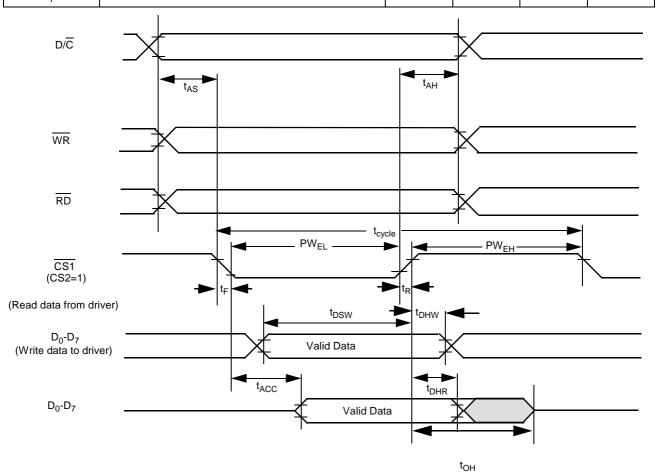


Figure 2. Parallel 8080-series Interface Timing Characteristics

6.4 Instruction Code

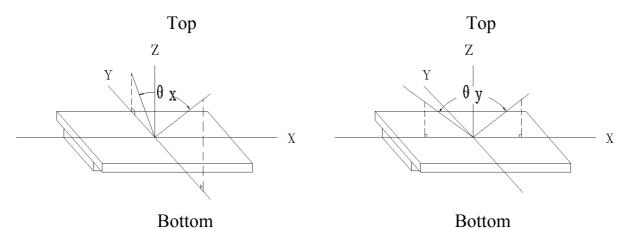
Bit Pattern	Write Command (D/ \overline{C} =0, R/ $\overline{W}(\overline{WR})$ =0, $\overline{E}(\overline{RD})$ =1)	Comment					
1010111X ₀	Set Display On/Off	$X_0=0$: turns off LCD panel (POR) $X_0=1$: turns on LCD panel					
01X ₅ X ₄ X ₃ X ₂ X ₁ X ₀	Set Display Start Line	Set display RAM display start line register from 0-63 using $X_5 X_4 X_3 X_2 X_1 X_0$. Display start line register is reset to 000000 during POR.					
1011X ₃ X ₂ X ₁ X ₀	Set Page Address	Set GDDRAM Page Address (0-8) using $X_3X_2X_1X_0$					
0001X ₃ X ₂ X ₁ X ₀	Set Higher Column Address	Set the higher nibble of the colume address register usir $X_3X_2X_1X_0$ as data bits. The initial display line register is reset 0000 during POR.					
0000X ₃ X ₂ X ₁ X ₀	Set Lower Column Address	Set the lower nibble of the colume address register using $X_3X_2X_1X_0$ as data bits. The initial display line register is reset to 0000 during POR.					
1010000X ₀	Set Segment Re-map	X_0 =0: column address 00H is mapped to SEG0 (POR) X_0 =1: column address 83H is mapped to SEG0 Refer to Fig. 5 for details.					
1010011X ₀	Set Normal/Reverse Display	X ₀ =0: normal display (POR) X ₀ =1: reverse display					
1010010X ₀	Set Entire Display On/Off	X ₀ =0: normal display (POR) X ₀ =1: entire display on					
1010001X ₀	Set LCD Bias	$X_0{=}0{:}1{/}9$ bias (POR) $X_0{=}1{:}1{/}7$ bias For setting bias ratio to 1/4, 1/5, 1/6 or 1/8, see Extended Command Table.					
11100000	Set Read-Modify-Write Mode	Read-modify-write mode will be entered in which the column address will not be incremented during display data read					
11101110	Set End of Read-Modify-Write Mode	Exit Read-modify-write mode. Column address before entering the mode will be restored					
11100010	Software Reset	Initialize the internal status					
1100X ₃ * * *	Set COM Output Scan Direction	X ₃ =0: normal mode (POR) X ₃ =1: remapped mode. COM0 to COM[N-1] becomes COM[N-1] to COM0 in Multiplex ratio is equal to N. See Fig.5 as an example for N equal to 64.					
00101X ₂ X ₁ X ₀	Set Power Control Register	$X_0=0$: turns off the output op-amp buffer (POR) $X_0=1$: turns on the output op-amp buffer $X_1=0$: turns off the internal regulator (POR) $X_1=1$: turns on the internal regulator $X_2=0$: turns off the internal voltage booster (POR) $X_2=1$: turns on the internal voltage booster					
00100X ₂ X ₁ X ₀	Set Internal Regulator Resistor Ratio	Internal regulator gain increases as $X_2 X_1 X_0$ increased from 000b to 111b.					
10000001 * * X ₅ X ₄ X ₃ X ₂ X ₁ X ₀	Set Contrast Control Register	Set Contrast level from 64 contrast steps. Contrast increases as $X_5X_4X_3X_2X_1X_0$ is increased. $X_5X_4X_3X_2X_1X_0 = 100000b$ (POR)					
1010110X ₀	Set Indicator On/Off	$X_0 = 0$: indicator off (POR, no need of second command byte) $X_0 = 1$: indicator on (second command byte required)					
* * * * * * X ₁ X ₀	Indicator Display Mode, This second byte command is required ONLY when "Set Indicator On" com- mand is sent.						
* * * * * * *	Set Power Save Mode	Standby or sleep mode will be entered with compound commands					
11100011	NOP	Command for No Operation					
1111 * * * *	Set Test Mode	Reserved for IC testing. Do NOT use.					
11110000	Test Mode Reset	Reserved for IC testing. Do NOT use.					

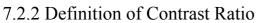
7 Optical Characteristics

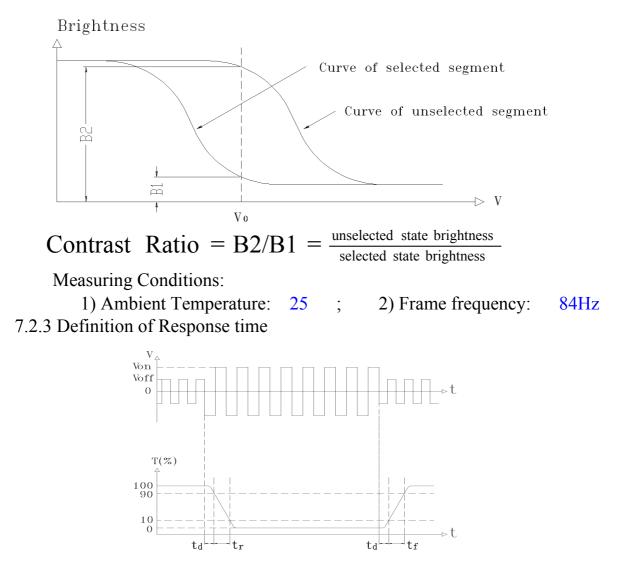
7 1 Optical Characteristics

7.1 Optical Characteristics Ta=25										
Item		Symbol	Condition		Min.	Тур.	Max.	Unit		
Victoria	A	x y=0 °		-30 20			Dee			
Viewing A	Angle	у	Cr≥2 x=0		-30 30			Deg		
Contrast	Ratio	Cr	$x=0 \circ$ $y=0 \circ$		3.0	-	-			
Response	Turn on	Ton	$x=0 \circ y=0 \circ$		_x =0 °		-	-	300	ms
Time	Turn off	Toff			-	-	300	ms		

7.2 Definition of Optical Characteristics7.2.1 Definition of Viewing Angle







Turn on time: $t_{on} = t_d + t_r$ Turn off time: $t_{off} = t_d + t_f$ Measuring Condition:

1) Operating Voltage: 10.0V 2) Frame frequency: 84Hz

8 Reliability

8.1 0	Content of Reliability	Ta=25	
No.	Test Item	Content of Test	Test condition
1	High Temperature Storage	Endurance test applying the high storage temperature for a long time	80 240H Restore 4H at 25
2	Low Temperature Storage	Endurance test applying the low storage temperature for a long time	-35 240H Restore 4H at 25
3	High Temperature Operation	Endurance test applying the electric stress (voltage & current) and the thermal stress to the element for a long time	70 240H
4	Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time	-25 240H
5	High Temperature /Humidity Storage	Endurance test applying the high temperature and high humidity storage for a long time	60 95%RH 240H Restore 4H at 25
6	Temperature Cycle	Endurance test applying the low and high temperature cycle -35 25 80 25 30min 5min 30min 5min 1 cycle	-35 /80 10 cycles
7	Vibration Test (package state)	Endurance test applying the vibration during transportation	10Hz~500Hz, 100m/s ² , 120min
8	Shock Test (package state)	Endurance test applying the shock during transportation	Half- sine wave, 300m/s ² , 18ms
9	Atmospheric Pressure Test	Endurance test applying the atmospheric pressure during transportation by air	25kPa 16H Restore 2H

8.2 Failure Judgment Criterion

Criterion	Test Item No.									Failura Judgement Criterian
Item	1	2	3	4	5	6	7	8	9	Failure Judgement Criterion
Basic Specification							\checkmark	\checkmark	\checkmark	Out of the basic Specification
Electrical specification										Out of the electrical specification
Mechanical Specification							\checkmark	\checkmark		Out of the mechanical specification
Optical Characteristic									\checkmark	Out of the optical specification
Note	For test item refer to 8.1									
Remark	Basic specification = Optical specification + Mechanical specification									

9 QUALITY LEVEL

Examination	At T _a =25	Inspection				
or Test	(unless otherwise stated)	Min.	Max.	Unit	IL	AQL
External Visual Inspection	Under normal illumi-nation and eyesight condition, the dis-tance between eyes and LCD is 25cm.	See Appendix A			II	Major 1.0 Minor 2.5
Display Defects	Undernormalillumi-nationandeyesightcondition,display on inspection.	See Appendix B		Π	Major 1.0 Minor 2.5	
Note: Major defects: Open segment or common, Short, Serious damages, Leakage Miner defects: Others Sampling standard conforms to GB2828						

10 Precautions for Use of LCD Modules

- 10.1 Handling Precautions
- 10.1.1 The display panel is made of glass. Do not subject it to a mechanical shock by dropping it from a high place, etc.
- 10.1.2 If the display panel is damaged and the liquid crystal substance inside it leaks out, be sure not to get any in your mouth, if the substance comes into contact with your skin or clothes, promptly wash it off using soap and water.
- 10.1.3 Do not apply excessive force to the display surface or the adjoining areas since this may cause the color tone to vary.
- 10.1.4 The polarizer covering the display surface of the LCD module is soft and easily scratched. Handle this polarizer carefully.
- 10.1.5 If the display surface is contaminated, breathe on the surface and gently wipe it with a soft dry cloth. If still not completely clear, moisten cloth with one of the following solvents:
 - Isopropyl alcohol
 - Ethyl alcohol

Solvents other than those mentioned above may damage the polarizer. Especially, do not use the following:

- Water
- Ketone
- Aromatic solvents
- 10.1.6 Do not attempt to disassemble the LCD Module.
- 10.1.7 If the logic circuit power is off, do not apply the input signals.
- 10.1.8 To prevent destruction of the elements by static electricity, be careful to maintain an optimum work environment.
 - a. Be sure to ground the body when handling the LCD Modules.
 - b. Tools required for assembly, such as soldering irons, must be properly ground.
 - c. To reduce the amount of static electricity generated, do not conduct assembly and other work under dry conditions.
 - d. The LCD Module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

10.2 Storage precautions

10.2.1 When storing the LCD modules, avoid exposure to direct sunlight or to the light of fluorescent lamps.

10.2.2 The LCD modules should be stored under the storage temperature range.

If the LCD modules will be stored for a long time, the recommend condition is:

Temperature :0~ 40Relatively humidity:80%

- 10.2.3 The LCD modules should be stored in the room without acid, alkali and harmful gas.
- 10.3 The LCD modules should be no falling and violent shocking during transportation, and also should avoid excessive press, water, damp and sunshine.

Appendix A

Inspection items and criteria for appearance defects

Items	Contents	Criteria				
Leakage		Not permitted				
Rainbow		According to the limit specimen				
Polarizer	Wrong polarizer attachment	Not permitted				
	Bubble between	Not counted		Max. 3 defects allowed		
	polarizer and glass	ф<0.3mm		0.3mm ø 0.51	n ø 0.5mm	
	Scratches of polarizer	According to the limit specimen				
Black spot (in viewing area)		Not counted	Max. 3 spots allowed		Max. 3	
		X<0.2mm	0.2mm X 0.5mm			
		X=(a+b)/2			spots (lines)	
Black line (in viewing area)		Not counted	Max	. 3 lines allowed	allowed	
		a<0.02mm	0.021	mm a 0.05mm b 2.0mm		
Progressive cracks		Not permitted				

Appendix B

Inspection items and criteria for display defects

Items		Contents	Critera			
Open segment or open common		Not permitted				
Short		Not permitted				
Wrong viewing angle		Not permitted				
Contrast radio uneven		According to the limit specimen				
Crosstalk		According to the limit specimen				
Pin holes and cracks in segment (DOT)		$h \vdash n$	Not counted	Max.3 dots allowed		
		X<0.1mm	0.1mm X 0.2mm			
		X=(a+b)/2		Max.3 dots		
	I	Not counted	Max.2 dots allowed	allowed		
		A<0.1mm	0.1mm A 0.2mm D<0.25mm			
Black spot (in viewing area)	spot	Not counted	Max.3 spots allowed			
			X<0.1mm	0.1mm X 0.2mm		
		X=(a+b)/2	Max.3 spots			
Black line (in viewing area)		Not counted	Max.3 lines allowed	- (lines) allowed		
		a<0.02mm	0.02mm a 0.05mm b 0.5mm			

Appendix B

Inspection items and criteria for display defects (continued)

Items	Content	Critera			
	D-111-a	Not counted	Max. 2 defects allowed		
		x < 0.1mm	0.1mm x 0.2mm		
		x=(a+b)/2			
				Max.3	
		Not counted	Max. 1 defects allowed	defects allowed	
Transfor- mation of segment		a < 0.1mm	0.1mm a 0.2mm D>0		
		Max.2 defects allowed 0.8W a 1.2W			
		a=measured va W=nominal va			
	a				